



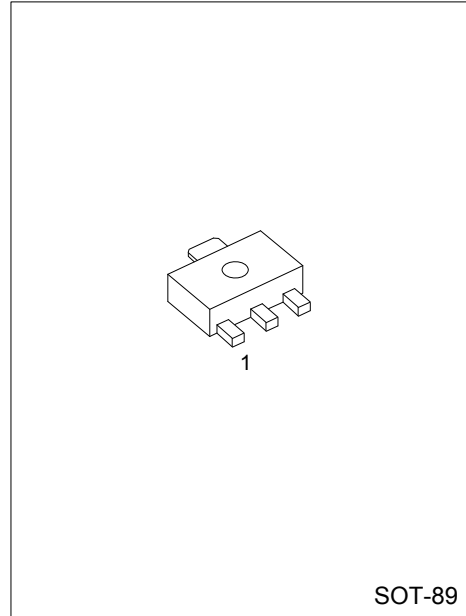
2SC3647

NPN SILICON TRANSISTOR

HIGH-VOLTAGE SWITCHING APPLICATIONS

FEATURES

- * High breakdown voltage and large current capacity
- * Fast switching time
- * Very small size marking it easy to provide high – density, small-sized hybrid ICs



Lead-free: 2SC3647L
 Halogen-free: 2SC3647G

ORDERING INFORMATION

Ordering Number		Package	Pin Assignment			Packing
Lead Free Plating	Halogen Free		1	2	3	
2SC3647L-x-AB3-R	2SC3647G-x-AB3-R	SOT-89	B	C	E	Tape Reel

<p>2SC3647L-x-AB3-R</p>	<p>(1) Packing Type</p> <p>(2) Package Type</p> <p>(3) Rank</p> <p>(4) Lead Plating</p>	<p>(1) R: Tape Reel</p> <p>(2) AB3: SOT-89</p> <p>(3) x: refer to Classification of h_{FE}</p> <p>(4) G: Halogen Free, L: Lead Free</p>
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■ ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

PARAMETER	SYMBOL	RATINGS	UNIT
Collector to Base Voltage	V _{CBO}	120	V
Collector to Emitter Voltage	V _{CEO}	100	V
Emitter to Base Voltage	V _{EBO}	6	V
Collector Current	I _C	2	A
Collector Current (Pulse)	I _{CP}	3	A
Collector Dissipation	P _C	500	mW
Junction Temperature	T _J	150	°C
Storage Temperature	T _{STG}	-40 ~ +150	°C

Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

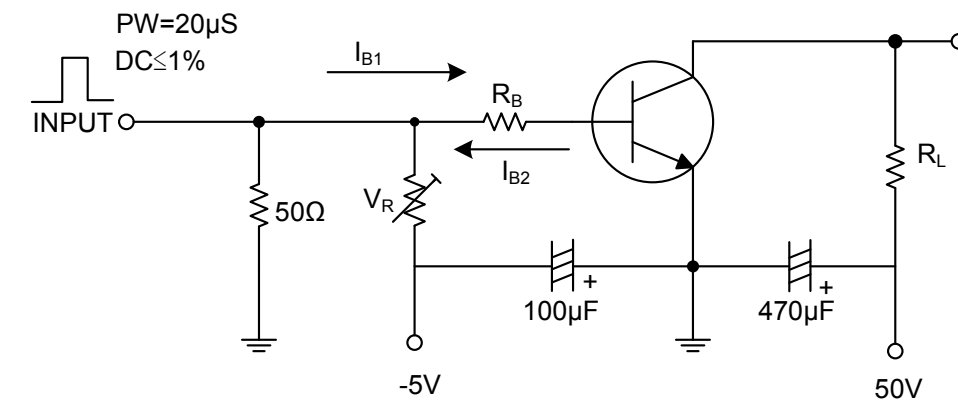
■ ELECTRICAL CHARACTERISTICS (Ta = 25°C, unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
Collector-Base Breakdown Voltage	BV _{CBO}	I _C = 10μA, I _E = 0	120			V
Collector-Emitter Breakdown Voltage	BV _{CEO}	I _C = 1mA, R _{BE} = ∞	100			V
Emitter-Base Breakdown Voltage	BV _{EBO}	I _E = 10μA, I _C = 0	6			V
Collector Cutoff Current	I _{CBO}	V _{CB} = 100V, I _E = 0			100	nA
Emitter Cutoff Current	I _{EBO}	V _{EB} = 4V, I _C = 0			100	nA
Collector-Emitter Saturation Voltage	V _{CE(SAT)}	I _C = 1A, I _B = 100mA		0.13	0.4	V
Base-Emitter Saturation Voltage	V _{BE(SAT)}	I _C = 1A, I _B = 100mA		0.85	1.2	V
Output Capacitance	C _{ob}	V _{CB} = 10V, f = 1MHz		16		pF
DC Current Gain	h _{FE}	V _{CE} = 5V, I _C = 100mA	100		400	
Turn-ON Time	t _{ON}	See specified Test Circuit.		80		ns
Storage Time	t _{STG}	See specified Test Circuit.		1000		ns
Fall Time	t _F	See specified Test Circuit.		50		ns
Gain-Bandwidth Product	f _T	V _{CE} = 10V, I _C = 100mA		120		MHz

■ CLASSIFICATION OF h_{FE}

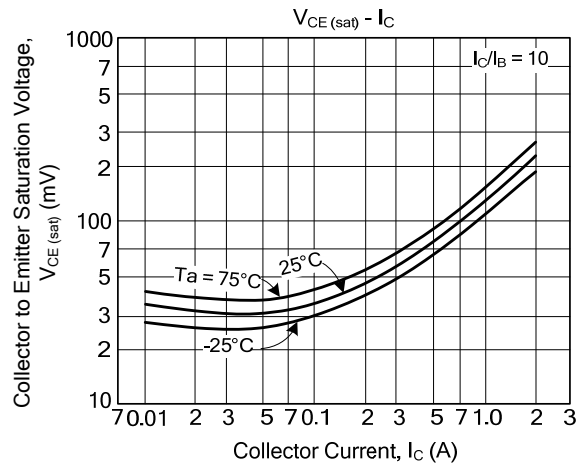
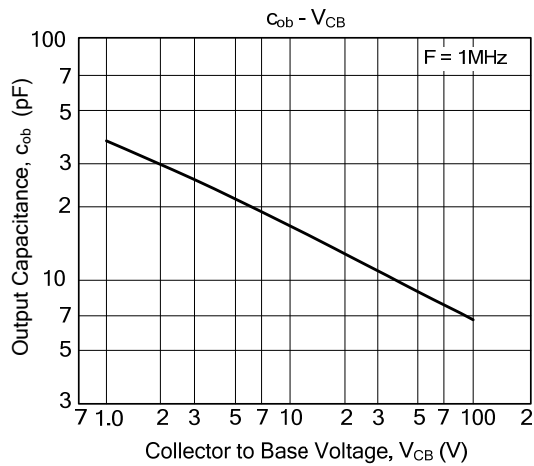
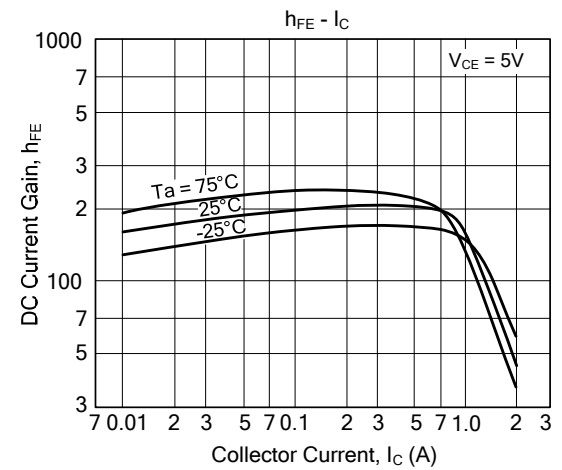
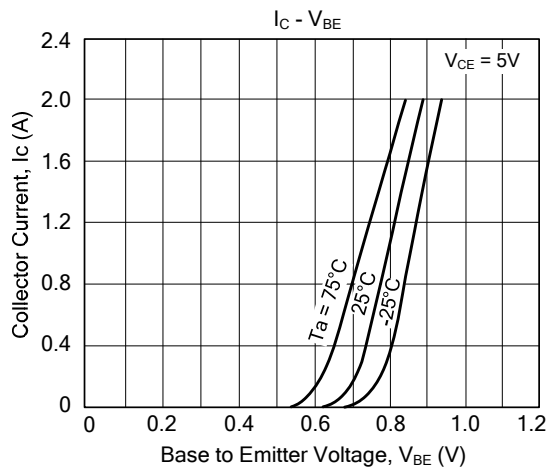
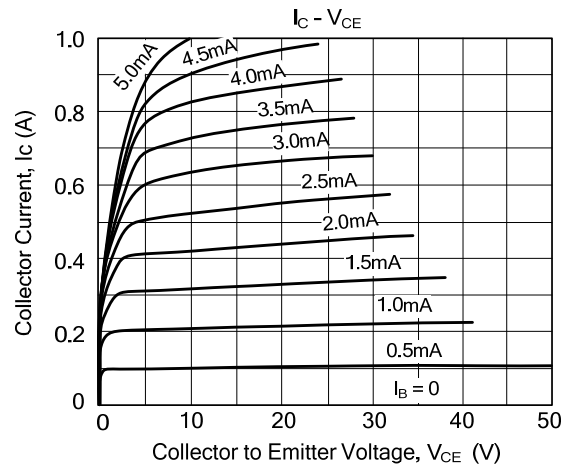
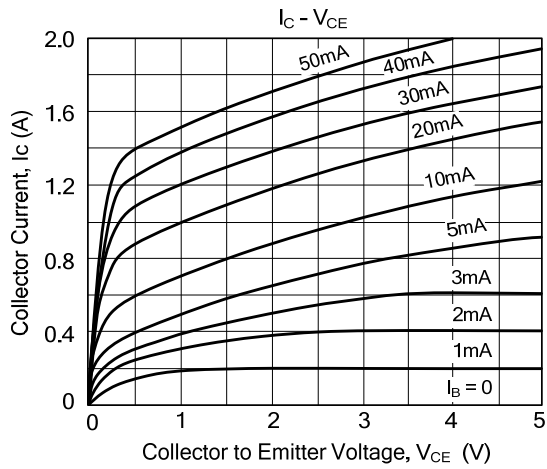
RANK	R	S	T
RANGE	100 ~ 200	140 ~ 280	200 ~ 400

■ SWITCHING TIME TEST CIRCUIT

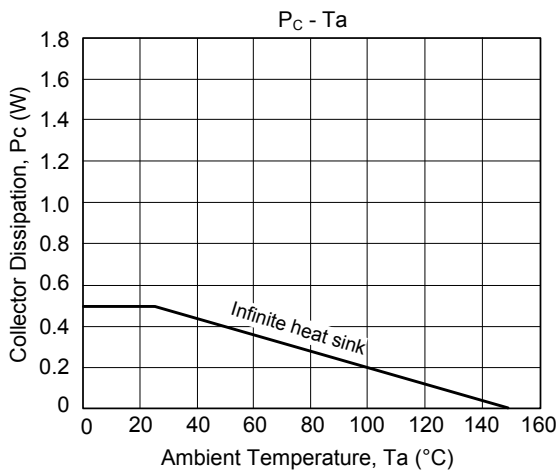
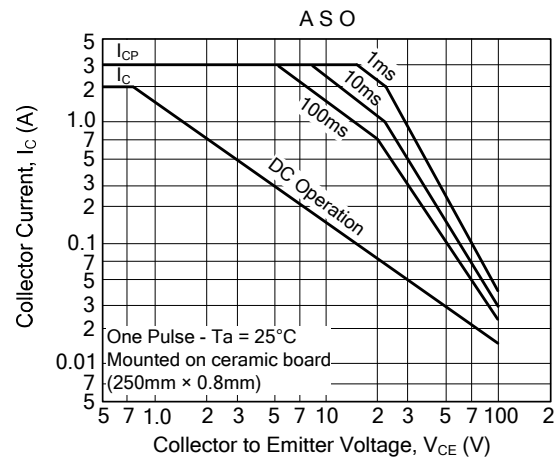
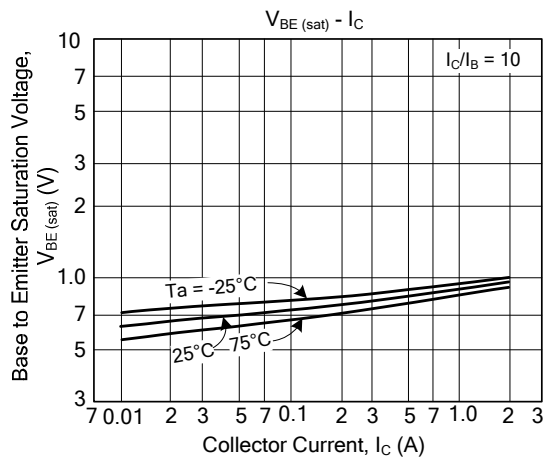


$$10I_{B1} = -10I_{B2} = I_C = 0.7A$$

TYPICAL CHARACTERISTICS



■ TYPICAL CHARACTERISTICS(Cont.)



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